

Search Notes

Application/Control No.

10/612,461

Examiner

Sheela C. Chawan

Applicant(s)/Patent under
Reexamination

CURRY ET AL.

Art Unit

2624

SEARCHED


Class	Subclass	Date	Examiner
382	154,	8/31/2006	SCC
"	162-173	8/31/2006	"
"	232,254,	8/31/2006	"
"	260,266	8/31/2006	"
"	270,274	8/31/2006	"
"	298,300	8/31/2006	"
"	305	8/31/2006	"
345	601-602	8/31/2006	"
"	604,606	8/31/2006	"
"	660	8/31/2006	"

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US-PGPUB,USPAT, USOCR, FPRS,EPO,JPO,DERWENT,IBM- TDB.	8/31/2006	SCC
INVENTOR NAME SEARCH.	8/31/2006	"

Search Notes 	Application/Control No. 10612461	Applicant(s)/Patent Under Reexamination CURRY ET AL.
	Examiner Chawan, Sheela C	Art Unit 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	162,168,274	1/6/07	SCC
345	601,604	1/6/07	SCC
358	1.9,518	1/6/07	SCC
ABOVE SEARCH UP-DATE.		1/6/07	SCC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST,US-PGPUB,USPAT,EPO,JPO,DERWENT,IBM-TDB, SEE SEARCH HISTORY.	1/6/07	SCC
382/162,168,274.CCLS.	1/6/07	SCC
345/601,604.CCLS.	1/6/07	SCC
358/1.9,518.CCLS. US-PATENT ONLY, SEE TEXT SEARCH.	1/6/07	SCC
SEARCH UP-DATE.	1/6/07	SCC
INTERFERENCE SEARCH SEE SEARCH HISTORY.	1/6/07	SCC
INVENTOR NAME SEARCH,	1/6/07	SCC
IEEE OR INSPEC SEARCH.	1/6/07	SCC
CONSULTED WITH SAMIR AHMED ART UNIT: 2624	1/6/07	SCC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
382	154,162,168,274	1/6/07	SCC
345	601,604	1/6/07	SCC
358	1.9,518	1/6/07	SCC